

Reconstruction of discontinuous functions by perimeter penalization

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Electrical Impedance Tomography

Reconstruction of discontinuous conductivities

Electrical Impedance Tomography: the forward problem

$\Omega \subset \mathbb{R}^N$ ($N \geq 2$) bounded domain, $\partial\Omega$ Lipschitz

conductivity $\sigma : \Omega \rightarrow \mathbb{R}$ measurable and uniformly elliptic

$$0 < \lambda \leq \sigma \leq \lambda^{-1} \quad \text{a.e. in } \Omega$$

prescribed current density $f \in H_*^{-1/2}(\partial\Omega)$ where

$$H_*^{-1/2}(\partial\Omega) = \{f \in H^{-1/2}(\partial\Omega) : f \text{ has zero mean}\}$$

electrostatic potential u solution to the forward problem

$$(1) \quad \begin{cases} \operatorname{div}(\sigma \nabla u) = 0 & \text{in } \Omega \\ \sigma \nabla u \cdot \nu = f & \text{on } \partial\Omega \\ \int_{\partial\Omega} u = 0 \end{cases}$$

Electrical Impedance Tomography: the inverse problem

Unknown

- conductivity σ

Available data

- Neumann-to-Dirichlet map $\Lambda(\sigma) : H_*^{-1/2}(\partial\Omega) \rightarrow H_*^{1/2}(\partial\Omega)$

$$\Lambda(\sigma)[f] = u|_{\partial\Omega} \in H_*^{1/2}(\partial\Omega) \quad \text{for any } f \in H_*^{-1/2}(\partial\Omega),$$

u solution to the forward problem (1)

Inverse conductivity problem (Calderón 1980)

Determine the conductivity σ from electrostatic measurements on the boundary, that is by measuring the Neumann-to-Dirichlet map $\Lambda(\sigma)$

Uniqueness

Does the Neumann-to-Dirichlet map $\Lambda(\sigma)$ uniquely determine the conductivity σ ? Is the forward function $\sigma \rightarrow \Lambda(\sigma)$ injective?

$N \geq 3$ Kohn & Vogelius (1984) — Sylvester & Uhlmann (1987) (σ regular)
Isakov (1988) (σ piecewise regular)

$N = 2$ Nachman (1995) (σ regular) — Astala & Päivärinta (2006) ($\sigma \in L^\infty$)

Reconstruction

Numerically reconstruct σ from (an approximation of) $\Lambda(\sigma)$

Main difficulties

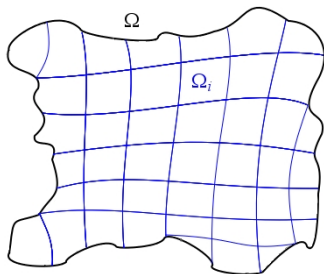
- nonlinear problem
- severely ill-posed problem (Mandache (2001), σ regular, $N \geq 2$)

Discontinuous conductivities: two particular cases (1)

Domain discretization

$$\Omega = \bigcup_{i=1}^n \Omega_i \quad \Omega_i \text{ assigned}$$

$$\sigma = \sum_{i=1}^n k_i \chi_{\Omega_i} \quad (\sigma \text{ piecewise constant})$$



Problem: determine the **unknown constants** k_i

- **Lipschitz stability** (Alessandrini & Vessella (2005))
- Lipschitz constant **exponentially exploding** as $n \rightarrow +\infty$ (Rondi (2006))

Discontinuous conductivities: two particular cases (2)

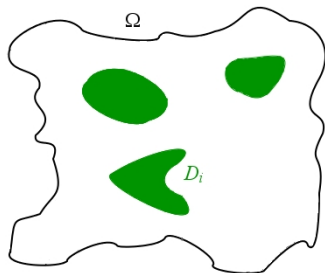
Inverse inclusion problem

$$\sigma = k_0 + \sum_{i=1}^n (k_i - k_0) \chi_{D_i}$$

$D_i \in \Omega$ D_i unknown inclusions

k_0 known background conductivity

k_i constants or functions known or not



Problem: determine the **unknown inclusions** D_i (and in case the coefficients k_i)

- **optimal stability** of logarithmic type (Alessandrini & Di Cristo (2005))
- **optimality** (Di Cristo & Rondi (2003))

Setup of the inverse problem

Let X be the set of measurable functions σ such that

- $0 < \lambda \leq \sigma \leq \lambda^{-1}$ a.e. in Ω
- σ belongs to some class of discontinuous functions (for example **piecewise constant** or **piecewise regular**)

Let $Y = \mathcal{L}(H_*^{-1/2}(\partial\Omega), H_*^{1/2}(\partial\Omega))$

Let $\Lambda : X \rightarrow Y$ be the forward function such that, for any $\sigma \in X$, $\Lambda(\sigma)$ is the Neumann-to-Dirichlet map associated to σ

Let $\sigma_0 \in X$ be the **unknown conductivity**, $\Lambda_0 = \Lambda(\sigma_0)$ and Λ_ε be the **approximate** (measured) **Neumann-to-Dirichlet map** such that

$$d_Y(\Lambda_0, \Lambda_\varepsilon) \leq \varepsilon$$

Setup of the inverse problem: reconstruction

Let $0 < \beta \leq \alpha$ and let us consider the regularized problem

$$\min_{\sigma \in X} d_Y(\Lambda(\sigma), \Lambda_\varepsilon)^\alpha + a\varepsilon^\beta R(\sigma)$$

$R : X \rightarrow [0, +\infty]$ **regularization operator** (usually R is a norm or a seminorm)
 $a\varepsilon^\beta > 0$ **regularization coefficient**

Main issue

How to choose the **regularization operator** R , and the **distances** d_X and d_Y , so that the following is guaranteed?

- (1) **existence of a minimizer**: σ_ε **minimizer** (regularized solution)
- (2) **convergence of minimizers**: $\lim_{\varepsilon \rightarrow 0^+} \sigma_\varepsilon = \sigma_0$

Examples of regularization operators

Total variation

$$R(\sigma) = TV(\sigma) = |D\sigma|(\Omega)$$

- Dobson & Santosa (1994) (discretization)
- Chan & Tai (2003) — Chung, Chan & Tai (2005) (level set)

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Mumford-Shah functional

$$R(\sigma) = MS(\sigma) = \int_{\Omega} |\nabla\sigma|^2 + \mathcal{H}^{N-1}(J(\sigma))$$

- Rondi & Santosa (2001) (Γ -convergence)

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Particular cases

Domain discretization

$$TV(\sigma) = \sum_{i < j} |k_i - k_j| \mathcal{H}^{N-1}(\partial\Omega_i \cap \partial\Omega_j)$$

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Particular cases

Inverse inclusion problem (inclusions D_i pairwise disjoint)

$$TV(\sigma) = \sum_i |k_i - k_0| P(D_i) \quad \text{or} \quad MS(\sigma) = \sum_i P(D_i)$$

$$P(D) = \mathcal{H}^{N-1}(\partial D) \text{ perimeter of } D$$

Convergence result (Rondi 2008)

Let $d_X(\sigma_1, \sigma_2) = \|\sigma_1 - \sigma_2\|_{L^1}$ and the regularization operator R be either the total variation or the Mumford-Shah functional

Theorem

Let us assume that $R(\sigma_0) < +\infty$ and $d_Y(\Lambda_1, \Lambda_2) = \|\Lambda_1 - \Lambda_2\|_{\mathcal{L}(L_*^2, L_*^2)}$

Let $\sigma_n = \sigma_{\varepsilon_n}$ be regularized solutions ($\varepsilon_n \rightarrow 0^+$)

If $N = 2$, then $\lim_n \sigma_n = \sigma_0$ in L^1

If $N \geq 3$ and $\beta < \alpha$, then, up to a subsequence, $\lim_n \sigma_n = \bar{\sigma}$ in L^1

where $\Lambda(\bar{\sigma}) = \Lambda_0 = \Lambda(\sigma_0)$ and

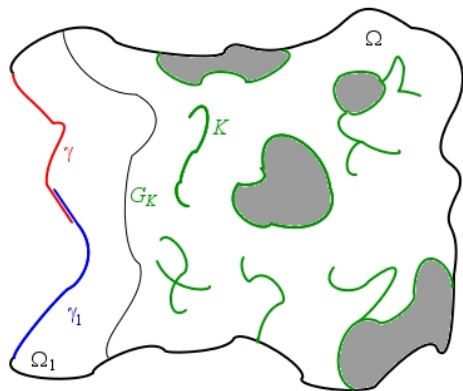
$$R(\bar{\sigma}) = \min\{R(\sigma) : \Lambda(\sigma) = \Lambda_0\}$$

Remark: for the case $N = 2$, it is crucial the uniqueness of the inverse problem guaranteed by Astala & Päivärinta (2006)

The inverse crack or cavity problem

A variational approach

Geometry of the forward problem



$\Omega \subset \mathbb{R}^N$ ($N \geq 2$)
bounded domain; $\partial\Omega$ Lipschitz
 K defect
 G_K partially known domain
(connected component of
 $\Omega \setminus K$ containing Ω_1)

K may consist simultaneously of (interior or surface-breaking) cracks, cavities, material losses at the boundary and other kinds of defects

The forward problem

K is a **perfectly insulating defect** in a (homogeneous and isotropic) conducting body Ω

$f \in L^s(\partial\Omega)$, $s > N - 1$, is the prescribed **current density** on $\partial\Omega$ such that

$$\text{supp}(f) \subset \gamma_1 \quad \text{and} \quad \int_{\gamma_1} f = 0$$

$u = u(f, K)$ is the **electrostatic potential** in Ω , (unique) solution to

$$(2) \quad \begin{cases} \Delta u = 0 & \text{in } \Omega \setminus K \\ \nabla u \cdot \nu = 0 & \text{on } \partial(\Omega \setminus K) \setminus \gamma_1 \\ \nabla u \cdot \nu = f & \text{on } \gamma_1 \\ \int_{\gamma} u = 0 \end{cases}$$

with the following **normalization**

$$(3) \quad u = 0 \quad \text{in } \Omega \setminus G_K$$

The inverse crack or cavity problem

K unknown perfectly insulating defect in Ω

f prescribed current density on γ_1

u electrostatic potential in Ω , solution to (2) with the normalization (3)

Measurement: $g = u|_{\gamma}$ is the measured voltage on γ

Remark: $g \in L^2(\gamma)$ such that

$$\int_{\gamma} g = \int_{\gamma} u = 0$$

Aim of the inverse problem

From one or more voltage and current measurements (prescribing the current f on γ_1 and measuring the corresponding voltage $g = u|_{\gamma}$ on γ), reconstruct the unknown defect K (or better ∂G_K)

Uniqueness for the inverse problem

Some references

uniqueness for cracks in 2D

Friedman & Vogelius (1989) — Bryan & Vogelius (1992)
Alessandrini & Diaz Valenzuela (1996) — Kim & Seo (1996)

uniqueness for surface-breaking cracks in 2D

Elcrat, Isakov & Neculoiu (1996) — Andrieux, Ben Abda & Jaoua (1998)

uniqueness for cavities and material losses at the boundary in 2D

Andrieux, Ben Abda & Jaoua (1993)

uniqueness for cracks in 3D

Alessandrini & Di Benedetto (1997) (planar cracks)
Eller (1996) (infinitely many measurements)

Solving the inverse problem: a two-steps procedure

Step 1: continuation from the Cauchy data

Cauchy data (g, f) \longrightarrow electrostatic potential u in Ω

Step 2: determination of the defect from the electrostatic potential

electrostatic potential u in Ω \longrightarrow defect K

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Determination of (a part of) K from features of the potential u (for example level sets, critical points, singularities, ...)

perfectly insulating defect K



$J(u) \subset \partial G_K$ $J(u)$ jump set of u

Solving the inverse problem: a two-steps procedure

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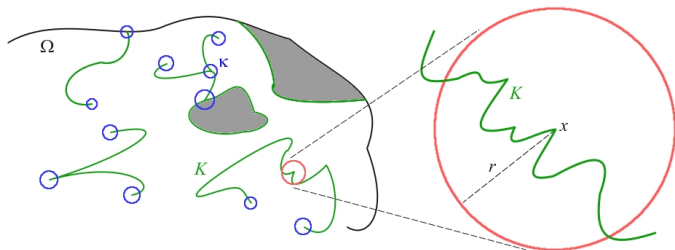
Step 1 by variational methods!

Admissible defects

K is an admissible defect if

$$K \subset \bar{\Omega} \text{ compact, } \text{dist}(K, \bar{\Omega}_1) \geq \rho, \quad \mathcal{H}^{N-1}(\partial G_K) < +\infty$$

and it is Lipschitz if, up to a closed set κ with $\mathcal{H}^{N-2}(\kappa) < +\infty$, ∂G_K is locally the graph of a Lipschitz function



Remark: K admissible defect $\Rightarrow u = u(f, K) \in SBV(\Omega)$ and

$$\|u\|_{L^\infty(\Omega)} + \|\nabla u\|_{L^2(\Omega)} \leq C_1 \|f\|_{L^s(\gamma_1)} \quad \mathcal{H}^{N-1}(J(u) \setminus \partial G_K) = 0$$

The uniqueness result (Rondi 2006)

Uniqueness Theorem

Let K_1 be a Lipschitz admissible defect and K_2 be an admissible defect

Let $u_1 = u(f, K_1)$ and $u_2 = u(f, K_2)$, and let $g_1 = u_1|_{\gamma}$ and $g_2 = u_2|_{\gamma}$

If $g_1 = g_2$, then

$$u_1 = u_2 \text{ almost everywhere in } \Omega$$

Corollary

Under the same assumptions, if $g_1 = g_2$, then

$$|G_{K_1} \Delta G_{K_2}| = 0$$

Application to the inverse cavity problem

A **defect** K is a material loss if G_K is the interior of its own closure

Remark: A material loss may contain **cavities** and **material losses** at the boundary but **not cracks**

Theorem

Under the same assumptions of the uniqueness theorem, let K_1 and K_2 be two material losses

If $g_1 = g_2$, then $G_{K_1} = G_{K_2}$

Remark: a single measurement may **not** be enough to uniquely determine a crack

Reconstruction for the cavities case: unknowns and data

Let K_0 be an **unknown material loss**, for example $K_0 = \partial\sigma_0$, $\sigma_0 = \bigcup_{i=1}^n D_i^0$

$D_i^0 \Subset \Omega$ D_i^0 pairwise disjoint **unknown cavities**, regular enough

Let $u_0 = u(f_0, K_0)$ and let $g_0 = u_0|_\gamma$

Unknowns: the material loss K_0 and the harmonic function u_0

Exact Cauchy data: Cauchy data (g_0, f_0)

Available data: noisy Cauchy data $(g_\varepsilon, f_\varepsilon)$ ($0 < \varepsilon \leq 1$) such that

$$f_\varepsilon \in L^s(\gamma_1), \quad \int_{\gamma_1} f_\varepsilon = 0 \quad g_\varepsilon \in L^2(\gamma), \quad \int_{\gamma} g_\varepsilon = 0$$

$$\|f_\varepsilon - f_0\|_{L^s(\gamma_1)} \leq \varepsilon \quad \text{and} \quad \|g_\varepsilon - g_0\|_{L^2(\gamma)} \leq \varepsilon$$

Aim

From the **noisy Cauchy data**, reconstruct u_0 and its **jump set** $J(u_0)$

Reconstruction: least-squares formulation

We look for $K = \partial\sigma$ solving, in a suitable class of admissible cavities, the minimization problem

$$\min_{K=\partial\sigma} \int_{\gamma} |u(f_{\varepsilon}, K) - g_{\varepsilon}|^2$$

$$\sigma = \bigcup_i D_i \quad D_i \Subset \Omega \quad D_i \text{ pairwise disjoint cavities}$$

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Main difficulties

- Numerically handling functionals depending on the shape of a set

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phase-field functions approach

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phase-field functions approach

- Instability

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phase-field functions approach

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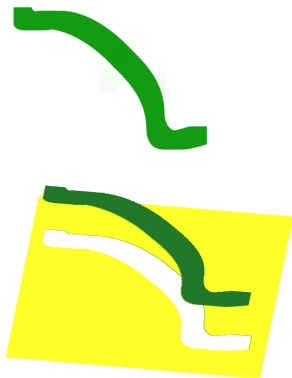
regularization by perimeter penalization

Phase-field functions approach: from the set to the characteristic function

$$u = u(f_\varepsilon, K), \quad K = \partial\sigma, \quad \sigma \in \Omega$$

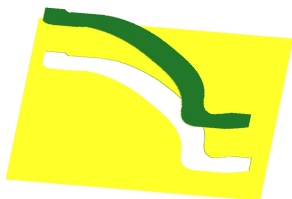
$$K = \partial\sigma \begin{cases} \Delta u = 0 & \text{in } \Omega \setminus \sigma \\ \nabla u \cdot \nu = 0 & \text{on } \partial\sigma \\ \nabla u \cdot \nu = f_\varepsilon & \text{on } \partial\Omega \\ \int_\gamma u = 0 \end{cases}$$

$$\chi_\sigma \begin{cases} \operatorname{div}((1 - \chi_\sigma)\nabla u) = 0 & \text{in } \Omega \\ \nabla u \cdot \nu = f_\varepsilon & \text{on } \partial\Omega \\ \int_\gamma u = 0 \end{cases}$$

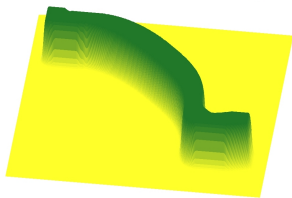


Phase-field functions approach: from the characteristic function to the phase-field function

$$\chi_\sigma \quad \begin{cases} \operatorname{div}((1 - \chi_\sigma)\nabla u) = 0 & \text{in } \Omega \\ \nabla u \cdot \nu = f_\varepsilon & \text{on } \partial\Omega \\ \int_\gamma u = 0 \end{cases}$$



$$0 \leq \tilde{v} \leq 1 \quad \begin{cases} \operatorname{div}((1 - \tilde{v})\nabla u) = 0 & \text{in } \Omega \\ \nabla u \cdot \nu = f_\varepsilon & \text{on } \partial\Omega \\ \int_\gamma u = 0 \end{cases}$$



phase-field function \tilde{v} \longrightarrow $v = 1 - \tilde{v}$ \longrightarrow
 \longrightarrow $v_\varepsilon = (1 - \varepsilon^2)\psi(v) + \varepsilon^2$ where $\psi(t) = -2t^3 + 3t^2$

The least-squares problem for phase-field functions

Given a phase-field function \tilde{v} , determine $u = u(f_\varepsilon, v_\varepsilon)$ solution to

$$\begin{cases} \operatorname{div}(v_\varepsilon \nabla u) = 0 & \text{in } \Omega \\ \nabla u \cdot \nu = f_\varepsilon & \text{on } \partial\Omega \\ \int_\gamma u = 0 \end{cases}$$

We look for a phase-field function $\tilde{v} \in H^1(\Omega, [0, 1])$ solving

$$\min_{\tilde{v}} \int_\gamma |u(f_\varepsilon, v_\varepsilon) - g_\varepsilon|^2 + \text{regularization}$$

Perimeter penalization



Modica-Mortola

The regularized problem

Let $W : \mathbb{R} \rightarrow \mathbb{R}$ be a continuous, nonnegative function such that $W(t) = 0$ if and only if $t \in \{0, 1\}$, $\beta > 0$ small enough

We look for a phase-field function $\tilde{v} \in H^1(\Omega, [0, 1])$ solving

$$\min_{\tilde{v}} \mathcal{F}_\varepsilon(v)$$

where

$$\mathcal{F}_\varepsilon(v) = \frac{1}{\varepsilon^\beta} \int_\gamma |u(f_\varepsilon, v_\varepsilon) - g_\varepsilon|^2 + \int_\Omega \left(v_\varepsilon |\nabla u(f_\varepsilon, v_\varepsilon)|^2 + \frac{W(v)}{\varepsilon} + \varepsilon |\nabla v|^2 \right)$$

Convergence result (Rondi 2009)

Let $\tilde{v}(\varepsilon)$, $\varepsilon > 0$, satisfy

$$\mathcal{F}_\varepsilon(v(\varepsilon)) \leq C$$

where $v(\varepsilon) = 1 - \tilde{v}(\varepsilon)$

Then, under a **technical assumption** on $\tilde{v}(\varepsilon)$, as $\varepsilon \rightarrow 0^+$ we have

- $v(\varepsilon)_\varepsilon u(f_\varepsilon, v(\varepsilon)_\varepsilon) \rightarrow u_0$ in $L^p(\Omega)$ for any $1 \leq p < +\infty$
- $v(\varepsilon)_\varepsilon \nabla u(f_\varepsilon, v(\varepsilon)_\varepsilon) \rightarrow \nabla u_0$ weakly in $L^2(\Omega)$
- $\overline{\{\tilde{v}(\varepsilon) > 1 - a\}} \rightarrow \sigma_0$ in the Hausdorff distance ($0 < a < 1$)